2.5 V / 3.3 V / 5.0 V 1:4 Clock Fanout Buffer

NB3L553

Description

The NB3L553 is a low skew 1-to 4 clock fanout buffer, designed for clock distribution in mind. The NB3L553 specifically guarantees low output-to-output skew. Optimal design, layout and processing minimize skew within a device and from device to device.

Features

- Input/Output Clock Frequency up to 200 MHz
- Low Skew Outputs (35 ps), Typical
- RMS Phase Jitter (12 kHz 20 MHz): 29 fs (Typical)
- Output goes to Three-State Mode via OE
- Operating Range: $V_{DD} = 2.375 \text{ V}$ to 5.25 V
- 5 V Tolerant Input Clock ICLK
- Ideal for Networking Clocks
- Packaged in 8-pin SOIC
- Industrial Temperature Range
- These are Pb-Free Devices

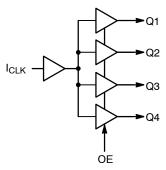


Figure 1. Block Diagram



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MARKING DIAGRAMS*



SOIC-8 D SUFFIX CASE 751



3L553 = Specific Device Code A = Assembly Location

L = Wafer Lot Y = Year W = Work Week ■ = Pb-Free Package



DFN8 MN SUFFIX CASE 506AA



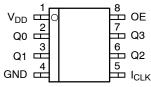
6P = Specific Device Code

 \overline{M} = Date Code

= Pb-Free Package

(Note: Microdot may be in either location)

PINOUT DIAGRAM



ORDERING INFORMATION

Device	Package	Shipping [†]
NB3L553DG	SOIC-8 (Pb-Free)	98 Units/Rail
NB3L553DR2G	SOIC-8 (Pb-Free)	2500/Tape & Reel
NB3L553MNR4G	DFN-8 (Pb-Free)	1000/Tape & Reel

[†]For information on tape and reel specifications, including part orientation and tape sizes, please refer to our Tape and Reel Packaging Specification Brochure, BRD8011/D.

^{*}For additional marking information, refer to Application Note AND8002/D.

Table 1. OE, OUTPUT ENABLE FUNCTION

OE	Function
0	Disable
1	Enable

Table 2. PIN DESCRIPTION

Pin#	Name	Туре	Description
1	V_{DD}	Power	Positive supply voltage (2.375 V to 5.25 V)
2	Q0	(LV)CMOS/(LV)TTL Output	Clock Output 0
3	Q1	(LV)CMOS/(LV)TTL Output	Clock Output 1
4	GND	Power	Negative supply voltage; Connect to ground, 0 V
5	I _{CLK}	(LV)CMOS Input	Clock Input. 5.0 V tolerant
6	Q2	(LV)CMOS/(LV)TTL Output	Clock Output 2
7	Q3	(LV)CMOS/(LV)TTL Output	Clock Output 3
8	OE	(LV)TTL Input	V_{DD} for normal operation. Pin has no internal pullup or pull down resistor for open condition default. Use from 1 to 10 kOhms external resistor to force an open condition default state.
-	EP	Thermal Exposed Pad	(DFN8 only) Thermal exposed pad must be connected to a sufficient thermal conduit. Electrically connect to the most negative supply (GND) or leave unconnected, floating open.

Table 3. MAXIMUM RATINGS

Symbol	Parameter	Condition 1	Condition 2	Rating	Unit
V _{DD}	Positive Power Supply	GND = 0 V	-	6.0	V
V _I	Input Voltage	OE I _{CLK}	GND = 0 V and V _{DD} = 2.375 V to 5.25 V	$\begin{aligned} & \text{GND} - 0.5 \leq V_{\text{I}} \leq V_{\text{DD}} + 0.5 \\ & \text{GND} - 0.5 \leq V_{\text{I}} \leq 5.75 \end{aligned}$	V
T _A	Operating Temperature Range, Industrial	-	-	≥ -40 to ≤ +85	°C
T _{stg}	Storage Temperature Range	-	-	-65 to +150	°C
θЈА	Thermal Resistance (Junction-to-Ambient)	0 Ifpm 500 Ifpm	SOIC-8	190 130	°C/W
θJC	Thermal Resistance (Junction-to-Case)	(Note 1)	SOIC-8	41 to 44	°C/W
$\theta_{\sf JA}$	Thermal Resistance (Junction-to-Ambient)	0 Ifpm 500 Ifpm	DFN8 DFN8	129 84	°C/W
θЈС	Thermal Resistance (Junction-to-Case)	(Note 1)	DFN8	35 to 40	°C/W

Stresses exceeding those listed in the Maximum Ratings table may damage the device. If any of these limits are exceeded, device functionality should not be assumed, damage may occur and reliability may be affected.

1. JEDEC standard multilayer board – 2S2P (2 signal, 2 power)

Table 4. ATTRIBUTES

Chara	Value			
ESD Protection	> 2 kV > 150 V > 2 kV			
Moisture Sensitivity, Indefinite	Time Out of Drypack (Note 2)	Level 1		
Flammability Rating	Oxygen Index: 28 to 34	UL-94 code V-0 @ 0.125 in		
Transistor Count	531 Devices			
Meets or Exceeds JEDEC Standard EIA/JESD78 IC Latchup Test				

^{2.} For additional Moisture Sensitivity information, refer to Application Note AND8003/D.

Table 5. DC CHARACTERISTICS (V_{DD} = 2.375 V to 2.625 V, GND = 0 V, T_A = -40°C to +85°C) (Note 3)

Symbol	Characteristic	Min	Тур	Max	Unit
I _{DD}	Power Supply Current @ 135 MHz, No Load	-	25	30	mA
V _{OH}	Output HIGH Voltage – I _{OH} = –16 mA	1.7	-	-	V
V _{OL}	Output LOW Voltage – I _{OL} = 16 mA	-	-	0.4	V
V _{IH,} I _{CLK}	Input HIGH Voltage, I _{CLK}	(V _{DD} ÷2)+0.5	-	5.0	V
V _{IL,} I _{CLK}	Input LOW Voltage, I _{CLK}	-	-	(V _{DD} ÷2)-0.5	V
V _{IH,} OE	Input HIGH Voltage, OE	1.8	-	V_{DD}	V
V _{IL,} OE	Input LOW Voltage, OE	-	-	0.7	V
ZO	Nominal Output Impedance	-	20	-	Ω
CIN	Input Capacitance, I _{CLK} , OE	-	5.0	-	pF
IOS	Short Circuit Current	-	± 28	-	mA

DC CHARACTERISTICS (V_{DD} = 3.15 V to 3.45 V, GND = 0 V, T_A = -40° C to $+85^{\circ}$ C) (Note 3)

Symbol	Characteristic		Тур	Max	Unit
I _{DD}	Power Supply Current @ 135 MHz, No Load	-	35	40	mA
V _{OH}	Output HIGH Voltage – I _{OH} = -25 mA	2.4	-	-	٧
V _{OL}	Output LOW Voltage – I _{OL} = 25 mA	-	-	0.4	٧
V _{OH}	V _{OH} Output HIGH Voltage – I _{OH} = –12 mA (CMOS level)		-	-	٧
V _{IH,} I _{CLK}	Input HIGH Voltage, I _{CLK}	(V _{DD} ÷2)+0.7	-	5.0	٧
V _{IL,} I _{CLK}	Input LOW Voltage, I _{CLK}	-	-	(V _{DD} ÷2)-0.7	٧
V _{IH,} OE	Input HIGH Voltage, OE	2.0	-	V_{DD}	٧
V _{IL,} OE	Input LOW Voltage, OE	0	_	0.8	V
ZO	ZO Nominal Output Impedance		20	-	Ω
CIN	CIN Input Capacitance, OE		5.0	_	pF
IOS	Short Circuit Current	_	± 50	_	mA

DC CHARACTERISTICS (V_{DD} = 4.75 V to 5.25 V, GND = 0 V, T_A = $-40^{\circ}C$ to $+85^{\circ}C$) (Note 3)

Symbol	ol Characteristic		Тур	Max	Unit
I _{DD}	Power Supply Current @ 135 MHz, - No Load	-	45	85	mA
V _{OH}	Output HIGH Voltage – I _{OH} = -35 mA	2.4	-	-	V
V _{OL}	Output LOW Voltage – I _{OL} = 35 mA	-	-	0.4	V
V _{OH}	V _{OH} Output HIGH Voltage – I _{OH} = –12 mA (CMOS level)		-	-	V
V _{IH,} I _{CLK}	Input HIGH Voltage, I _{CLK}	(V _{DD} ÷2) + 1	-	5.0	V
V _{IL,} I _{CLK}	Input LOW Voltage, I _{CLK}	-	-	(V _{DD} ÷2) – 1	V
V _{IH,} OE	Input HIGH Voltage, OE	2.0	-	V_{DD}	V
V _{IL,} OE	Input LOW Voltage, OE	-	-	0.8	V
ZO	ZO Nominal Output Impedance		20	-	Ω
CIN	Input Capacitance, OE	-	5.0	-	pF
IOS	Short Circuit Current	-	± 80	-	mA

Table 6. AC CHARACTERISTICS; V_{DD} = 2.5 V ±5% (V_{DD} = 2.375 V to 2.625 V, GND = 0 V, T_A = -40°C to +85°C) (Note 3)

Symbol	Characteristic	Min	Тур	Max	Unit
f _{in} Input Frequency		_	-	200	MHz
t _r /t _f	Output rise and fall times; 0.8 V to 2.0 V	-	1.0	1.5	ns
t _{pd}	Propagation Delay, CLK to Q _n (Note 4)	2.2	3.0	5.0	ns
t _{skew}	Output-to-output skew; (Note 5)	-	35	50	ps
t _{skew}	Device-to-device skew, (Note 5)	-	-	500	ps

AC CHARACTERISTICS; V_{DD} = 3.3 V ±5% (V_{DD} = 3.15 V to 3.45 V, GND = 0 V, T_{A} = -40°C to +85°C) (Note 3)

Symbol	Characteristic	Conditions	Min	Тур	Max	Unit
f _{in}	Input Frequency		-	-	200	MHz
t _{jitter} (φ)	RMS Phase Jitter (Integrated 12 kHz – 20 MHz) (See Figures 2 and 3)	f _{carrier} = 100 MHz	-	18	-	fs
t _r /t _f	Output rise and fall times; 0.8 V to 2.0 V		-	0.6	1.0	ns
t _{pd}	Propagation Delay, CLK to Q _n (Note 4)		2.0	2.4	4.0	ns
t _{skew}	Output-to-output skew; (Note 5)		-	35	50	ps
t _{skew}	Device-to-device skew, (Note 5)		ı	ı	500	ps

$\textbf{AC CHARACTERISTICS; V}_{DD} = \textbf{5.0 V} \pm \textbf{5\%} \ (V_{DD} = 4.75 \ V \ to \ 5.25 \ V, \ GND = 0 \ V, \ T_{A} = -40 ^{\circ} C \ to \ +85 ^{\circ} C) \ (Note \ 3)$

Symbol	Characteristic	Min	Min	Тур	Max	Unit
f _{in}	Input Frequency		-	-	200	MHz
t _{jitter} (φ)	RMS Phase Jitter (Integrated 12 kHz – 20 MHz) (See Figures 2 and 3)	f _{carrier} = 100 MHz	-	29	-	fs
t _r /t _f	Output rise and fall times; 0.8 V to 2.0 V		-	0.3	0.7	ns
t _{pd}	Propagation Delay, CLK to Q _n (Note 4)		1.7	2.5	4.0	ns
t _{skew}	Output-to-output skew; (Note 5)		-	35	50	ps
t _{skew}	Device-to-device skew, (Note 5)		-	-	500	ps

Product parametric performance is indicated in the Electrical Characteristics for the listed test conditions, unless otherwise noted. Product performance may not be indicated by the Electrical Characteristics if operated under different conditions. 3. Outputs loaded with external $R_L = 33~\Omega$ series resistor and $C_L = 15~pF$ to GND. Duty cycle out = duty in. A 0.01 μ F decoupling capacitor should

be connected between V_{DD} and GND.

4. Measured with rail-to-rail input clock

^{5.} Measured on rising edges at $V_{DD} \div 2$ between any two outputs with equal loading.

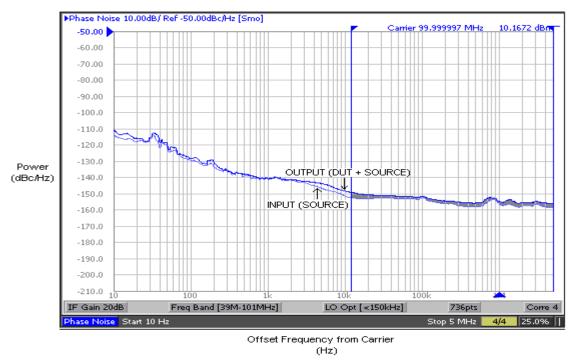


Figure 2. Phase Noise Plot at 100 MHz at an Operating Voltage of 3.3 V, Room Temperature

The above plot captured using Agilent E5052A shows Additive Phase Noise of the NB3L553 device measured with an input source generated by Agilent E8663B. The RMS phase jitter contributed by the device (integrated between 12 kHz to 20 MHz; as shown in the shaded area) is 18 fs (RMS Phase Jitter of the input source is 75.40 fs and Output (DUT+Source) is 93.16 fs).

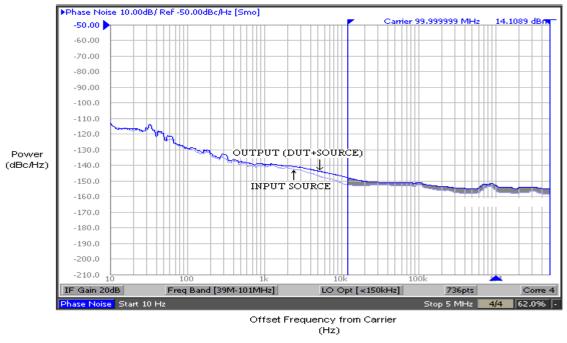


Figure 3. Phase Noise Plot at 100 MHz at an Operating Voltage of 5 V, Room Temperature

The above plot captured using Agilent E5052A shows Additive Phase Noise of the NB3L553 device measured with an input source generated by Agilent E8663B. The RMS phase jitter contributed by the device (integrated between 12 kHz to 20 MHz; as shown in the shaded area) is 29 fs (RMS Phase Jitter of the input source is 75.40 fs and Output (DUT+Source) is 103.85 fs).

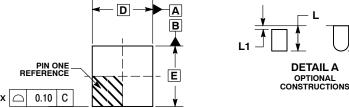




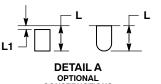
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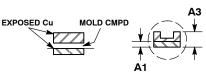
DFN8 2x2, 0.5P CASE 506AA **ISSUE F**

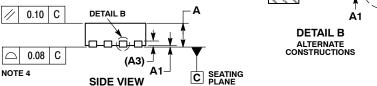
DATE 04 MAY 2016



TOP VIEW





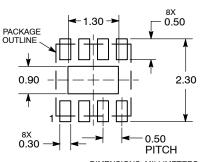


NOTES

- DIMENSIONING AND TOLERANCING PER
- ASME Y14.5M, 1994 . CONTROLLING DIMENSION: MILLIMETERS. DIMENSION & APPLIES TO PLATED TERMINAL AND IS MEASURED BETWEEN 0.15 AND 0.20 MM FROM TERMINAL TIP. COPLANARITY APPLIES TO THE EXPOSED
- PAD AS WELL AS THE TERMINALS.

	MILLIMETERS				
DIM	MIN	MIN MAX			
Α	0.80	.80 1.00			
A1	0.00	0.05			
А3	0.20	0.20 REF			
b	0.20	0.30			
D	2.00	BSC			
D2	1.10	1.30			
Е	2.00	BSC			
E2	0.70	0.90			
ө	0.50	BSC			
Κ	0.30	REF			
Ĺ	0.25	0.35			
L1		0.10			

RECOMMENDED SOLDERING FOOTPRINT*



DIMENSIONS: MILLIMETERS

DETAIL A ←D2 → 0.10 CAB е С 0.05 NOTE 3 **BOTTOM VIEW**

GENERIC MARKING DIAGRAM*



XX = Specific Device Code

= Date Code

= Pb-Free Device

*For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

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DESCRIPTION:	: DFN8, 2.0X2.0, 0.5MM PITCH		PAGE 1 OF 1

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^{*}This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.





SOIC-8 NB CASE 751-07 **ISSUE AK**

DATE 16 FEB 2011



- NOTES:
 1. DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
 CONTROLLING DIMENSION: MILLIMETER.
- DIMENSION A AND B DO NOT INCLUDE MOLD PROTRUSION.
- MAXIMUM MOLD PROTRUSION 0.15 (0.006) PER SIDE
- DIMENSION D DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE 0.127 (0.005) TOTAL IN EXCESS OF THE D DIMENSION AT MAXIMUM MATERIAL CONDITION.
- 751-01 THRU 751-06 ARE OBSOLETE. NEW STANDARD IS 751-07.

	MILLIMETERS		INCHES			
DIM	MIN	MAX	MIN	MAX		
Α	4.80	5.00	0.189	0.197		
В	3.80	4.00	0.150	0.157		
C	1.35	1.75	0.053	0.069		
D	0.33	0.51	0.013	0.020		
G	1.27	1.27 BSC		0.050 BSC		
Н	0.10	0.25	0.004	0.010		
J	0.19	0.25	0.007	0.010		
K	0.40	1.27	0.016	0.050		
М	0 °	8 °	0 °	8 °		
N	0.25	0.50	0.010	0.020		
S	5.80	6.20	0.228	0.244		

SOLDERING FOOTPRINT*



^{*}For additional information on our Pb-Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

GENERIC MARKING DIAGRAM*



XXXXX = Specific Device Code = Assembly Location = Wafer Lot = Year = Work Week W

= Pb-Free Package



XXXXXX = Specific Device Code = Assembly Location Α

= Year ww = Work Week = Pb-Free Package

*This information is generic. Please refer to device data sheet for actual part marking. Pb-Free indicator, "G" or microdot "•", may or may not be present. Some products may not follow the Generic Marking.

STYLES ON PAGE 2

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SOIC-8 NB CASE 751-07 ISSUE AK

DATE 16 FEB 2011

			DITTE TO LED 2
STYLE 1: PIN 1. EMITTER 2. COLLECTOR 3. COLLECTOR 4. EMITTER 5. EMITTER 6. BASE 7. BASE 8. EMITTER	STYLE 2: PIN 1. COLLECTOR, DIE, #1 2. COLLECTOR, #1 3. COLLECTOR, #2 4. COLLECTOR, #2 5. BASE, #2 6. EMITTER, #2 7. BASE, #1 8. EMITTER, #1	STYLE 3: PIN 1. DRAIN, DIE #1 2. DRAIN, #1 3. DRAIN, #2 4. DRAIN, #2 5. GATE, #2 6. SOURCE, #2 7. GATE, #1 8. SOURCE, #1	STYLE 4: PIN 1. ANODE 2. ANODE 3. ANODE 4. ANODE 5. ANODE 6. ANODE 7. ANODE 8. COMMON CATHODE
STYLE 5: PIN 1. DRAIN 2. DRAIN 3. DRAIN 4. DRAIN 5. GATE 6. GATE 7. SOURCE 8. SOURCE	STYLE 6: PIN 1. SOURCE 2. DRAIN 3. DRAIN 4. SOURCE 5. SOURCE 6. GATE 7. GATE 8. SOURCE	STYLE 7: PIN 1. INPUT 2. EXTERNAL BYPASS 3. THIRD STAGE SOURCE 4. GROUND 5. DRAIN 6. GATE 3 7. SECOND STAGE Vd 8. FIRST STAGE Vd	STYLE 8: PIN 1. COLLECTOR, DIE #1 2. BASE, #1 3. BASE, #2 4. COLLECTOR, #2 5. COLLECTOR, #2 6. EMITTER, #2 7. EMITTER, #1 8. COLLECTOR, #1
STYLE 9: PIN 1. EMITTER, COMMON 2. COLLECTOR, DIE #1 3. COLLECTOR, DIE #2 4. EMITTER, COMMON 5. EMITTER, COMMON 6. BASE, DIE #2 7. BASE, DIE #1 8. EMITTER, COMMON	STYLE 10: PIN 1. GROUND 2. BIAS 1 3. OUTPUT 4. GROUND 5. GROUND 6. BIAS 2 7. INPUT 8. GROUND	STYLE 11: PIN 1. SOURCE 1 2. GATE 1 3. SOURCE 2 4. GATE 2 5. DRAIN 2 6. DRAIN 2 7. DRAIN 1 8. DRAIN 1	STYLE 12: PIN 1. SOURCE 2. SOURCE 3. SOURCE 4. GATE 5. DRAIN 6. DRAIN 7. DRAIN 8. DRAIN
STYLE 13: PIN 1. N.C. 2. SOURCE 3. SOURCE 4. GATE 5. DRAIN 6. DRAIN 7. DRAIN 8. DRAIN	STYLE 14: PIN 1. N-SOURCE 2. N-GATE 3. P-SOURCE 4. P-GATE 5. P-DRAIN 6. P-DRAIN 7. N-DRAIN 8. N-DRAIN	8. DRAIN 1 STYLE 15: PIN 1. ANODE 1 2. ANODE 1 3. ANODE 1 4. ANODE 1 5. CATHODE, COMMON 7. CATHODE, COMMON 8. CATHODE, COMMON	STYLE 16: PIN 1. EMITTER, DIE #1 2. BASE, DIE #1 3. EMITTER, DIE #2 4. BASE, DIE #2 5. COLLECTOR, DIE #2 6. COLLECTOR, DIE #2 7. COLLECTOR, DIE #1 8. COLLECTOR, DIE #1
STYLE 17: PIN 1. VCC 2. V2OUT 3. V1OUT 4. TXE 5. RXE 6. VEE 7. GND 8. ACC STYLE 21: PIN 1. CATHODE 1	STYLE 18: PIN 1. ANODE 2. ANODE 3. SOURCE 4. GATE 5. DRAIN 6. DRAIN 7. CATHODE 8. CATHODE STYLE 22: PIN 1. I/O LINE 1	STYLE 19: PIN 1. SOURCE 1 2. GATE 1 3. SOURCE 2 4. GATE 2 5. DRAIN 2 6. MIRROR 2 7. DRAIN 1 8. MIRROR 1 STYLE 23: PIN 1. LINE 1 IN	STYLE 20: PIN 1. SOURCE (N) 2. GATE (N) 3. SOURCE (P) 4. GATE (P) 5. DRAIN 6. DRAIN 7. DRAIN 8. DRAIN STYLE 24: PIN 1. BASE
2. CATHODE 2 3. CATHODE 3 4. CATHODE 4 5. CATHODE 5 6. COMMON ANODE 7. COMMON ANODE 8. CATHODE 6	2. COMMON CATHODE/VCC 3. COMMON CATHODE/VCC 4. I/O LINE 3 5. COMMON ANODE/GND 6. I/O LINE 4 7. I/O LINE 5 8. COMMON ANODE/GND	2. COMMON ANODE/GND 3. COMMON ANODE/GND 4. LINE 2 IN 5. LINE 2 OUT 6. COMMON ANODE/GND 7. COMMON ANODE/GND 8. LINE 1 OUT	2. EMITTER 3. COLLECTOR/ANODE 4. COLLECTOR/ANODE 5. CATHODE 6. CATHODE 7. COLLECTOR/ANODE 8. COLLECTOR/ANODE
STYLE 25: PIN 1. VIN 2. N/C 3. REXT 4. GND 5. IOUT 6. IOUT 7. IOUT 8. IOUT	STYLE 26: PIN 1. GND 2. dv/dt 3. ENABLE 4. ILIMIT 5. SOURCE 6. SOURCE 7. SOURCE 8. VCC	STYLE 27: PIN 1. ILIMIT 2. OVLO 3. UVLO 4. INPUT+ 5. SOURCE 6. SOURCE 7. SOURCE 8. DRAIN	STYLE 28: PIN 1. SW_TO_GND 2. DASIC_OFF 3. DASIC_SW_DET 4. GND 5. V_MON 6. VBULK 7. VBULK 8. VIN
STYLE 29: PIN 1. BASE, DIE #1 2. EMITTER, #1 3. BASE, #2 4. EMITTER, #2 5. COLLECTOR, #2 6. COLLECTOR, #2 7. COLLECTOR, #1 8. COLLECTOR, #1	STYLE 30: PIN 1. DRAIN 1 2. DRAIN 1 3. GATE 2 4. SOURCE 2 5. SOURCE 1/DRAIN 2 6. SOURCE 1/DRAIN 2 7. SOURCE 1/DRAIN 2 8. GATE 1		

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